

Erratum:

Erratum to: Determination of cut-off time of accelerated aging test under temperature stress for LED lamps

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In the original version of this article, the second affiliation should be removed, and the correct affiliations are as given above.

In the original version of this article, the ORCID for Jian HAO is incorrect. The correct one should be <http://orcid.org/0000-0002-2419-2508>.

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